Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10567701	CHEN ET AL.
Examiner	Art Unit
JAE Y LEE	2466

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
370/310,313,349,389,401 (US-PGPUB;USPAT)	9/16/2008	JL (JL)
	(Updated on	
	3/24/2009,	
	10/6/2009,	
	5/4/2010)	
EAST (US-	9/16/2008	JL (JL)
PGPUB;USPAT;USOCR;FPRS;EPO;JPO;DERWENT;IBM_TDB)-See	(Updated on	
Search History Printout	3/24/2009,	
	10/6/2009,	
	5/4/2010)	
Inventor Search	9/16/2008	JL (JL)
	(Updated on	
	3/24/2009,	
	10/6/2009,	
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INTERFERENCE SEARCH			
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